

PCIe-1149.1

# PCIe-1149.1 High-Speed PCI Express Bus Boundary-Scan Controller

**User's Manual** 

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## Chapter 1 Product Overview

## Introduction

The PCIe-1149.1 High-Speed PCI Express Bus boundary-scan controller is a member of the Corelis ScanExpress<sup>™</sup> family of high performance scan-based test, analysis, and diagnostic tools. The PCIe-1149.1 High-Speed PCI Express (PCIe) Bus Boundary-Scan Controller card, with memorybehind-the-pin architecture, interfaces between a host computer and any IEEE Standard 1149.1 compatible target. The PCIe-1149.1 is designed to control the operation of an IEEE Standard 1149.1 boundary-scan test path by generating the proper signals under software control to interface with the target system. It also supports remote operation of multiple boundary-scan (JTAG) Test Access Ports (TAPs) using any of the Corelis ScanTAP family of Multiple TAP Intelligent pods such as the ScanTAP-4, ScanTAP-8 or ScanTAP-32. The PCIe-1149.1 is shown in Figure 1-1.



Figure 1-1. The Corelis PCIe-1149.1 Boundary-Scan Controller

The most popular Intelligent Pod is the ScanTAP-4. It connected to the PCIe-1149.1 card via a standard SCSI-II cable and it provides up to 4 independent TAP connectors with a programmable low-voltage-compatible interface. Each of the 4 TAP connectors contains direct access to JTAG, I2C and SPI interfaces. It also supports simultaneous programming and verification of Flash memory devices at continuous scan clock (TCK) speeds of up to 80 MHz. The ScanTAP pods include direct hardware compare of expected scan results and are therefore especially suitable for gang (parallel) testing and programming of units under test (UUTs).

The PCIe-1149.1 facilitates software-controlled boundary-scan operations per IEEE Standard 1149.1. It provides command access to the target's Test Access Port (TAP), to verify PCB interconnects, perform functional testing, and debug without manual probing. Furthermore, the JTAG interface gives access to internal device functions that are not accessible via external probing, enabling fault isolation within the device itself. The JTAG interface also enables programming target Flash and CPLD devices, as well as downloading and uploading of data blocks to and from various storage devices. Application software for the PCIe-1149.1 is sold separately.

### What Is IEEE Standard 1149.1?

The IEEE Standard 1149.1 test bus and boundary-scan architecture enable control of an IC, board, or system, via a standard four-signal interface. Each IEEE Standard 1149.1-compliant IC incorporates a feature known as boundary-scan, which ensures that a JTAG controller can control and observe each functional pin of the IC via the four-wire interface. A controller can load test, debug, or initialization patterns serially into the appropriate IC(s) via the IEEE Standard 1149.1 test bus. Thus, even with limited physical access, a user can observe or control IC, board, or system functions.

Two main elements comprise the IEEE Standard 1149.1 test bus: a Test Access Port (TAP), which interfaces internal IC logic with the external world via a four-signal (optionally five-signal) bus as shown in Figure 1-2, and a boundary-scan architecture, which defines standard boundary cells that drive and receive data at the IC pins. IEEE Standard 1149.1 also defines both mandatory and optional opcodes and test features. The test bus signals are: Test Clock (TCK), Test Mode Select (TMS), Test Data In (TDI), Test Data Out (TDO), and the optional Test Logic Reset (TRST).

The IEEE-1149.1 Test Access Port		
Interface (TAP) consists of four	TMS	
required signals:		-
Test Mode Select (TMS)	TCK	
Test Clock (TCK)	TDI	
Test Data In (TDI)		
	TDO	
Test Data Out (TDO)	TDOT	P
A fifth signal is defined as optional:	TRST*	•
Test Reset (TRST*)		

Figure 1-2. Test Access Port (TAP)

## Features of the PCIe-1149.1

The Corelis PCIe-1149.1 is a high performance JTAG controller that can access devices, boards or systems compliant with IEEE Standard 1149.1. This PCI Express bus compatible card directly supports one JTAG boundary-scan chain (TAP), expandable to additional TAPs using ScanTAP intelligent pods. Two general purpose 8-bit parallel I/O ports are also provided for test and/or control of non-boundary-scan areas of the unit under test (UUT). With its software-controlled voltage translating logic, the PCIe-1149.1 can test low voltage systems. The SCSII type connector includes high high-speed differential signals for reliable interfacing to external ScanTAP pods and it supports high speed gang (parallel) testing and programming of multiple UUTs.

The PCIe-1149.1 contains several performance enhancing functional sections aimed at increasing test vector throughput. A functional block diagram of the PCIe-1149.1 is shown in Figure 1-3. Key functional elements include the TAP controller, and the memory resources that support it. The on-board memory provides scan data storage and can store the entire scan data for maximum performance, real-time scan operations.

A test system accesses the TAP controller and its associated memory through the host PCI Express bus memory-mapped I/O. This supports the high data rate of the PCI Express bus, regardless of actual test clock speeds. The ability to download information into these memory elements further decouples the scan operations from the host software. A state machine that contains status and control registers accessible through the PCI Express bus controls all functions of the PCIe-1149.1.



Figure 1-3. PCIe-1149.1 Block Diagram

The PCIe-1149.1 TAP controller contains special autonomous hardware accelerator mechanisms to greatly increase performance where scan patterns repeat numerous times. This applies to target download/upload sequences conveying large data blocks. As a result, time consuming tasks such as

flash programming and emulator data transfers are more efficient for a given clock rate. This mechanism off-loads the host interaction requirements by generating repeated vectors internally, using host pre-loaded memory information. After host initialization, this mode of operation results in continuous and maximal scanning rates at all clock frequencies. The only exception occurs when the target paces the sequence by indicating a non-ready completion of data transfer, requiring a rescan of the target's status. When not in this special mode, the scan stream bursts at the programmed TCK rate, as paced by the flow of vector bits from the host.

Another performance enhancement provides hardware expected-value verification of scanned-back data at programmable chain positions. Thus, the target output stream is evaluated without host intervention and accompanying process delays. This further supports the above autonomous operation enabling the scanning sequence to loop and rescan until the desired feedback is supplied, also without host intervention.

A programmable, time delay skew compensation mechanism supports the PCIe-1149.1's high clock rates. This accommodates the returned target scan stream delays due to signal travel time down and up the cables. It can also adjust for a target's on-board TCK-to-TDO response delay.

An auxiliary feature of the PCIe-1149.1 is the target power-shorted detector for two voltages sense target interface pins. With the target un-powered, this mechanism effectively measures the impedance of the target load for each of two possible connected voltages, determining if a short exists (some unacceptably low impedance). If this impedance is less than about 1 ohm (about an 11 watt target or greater at 3.3V, for example), it is deemed shorted.

## Adjustable Voltage Interfaces

The software-programmable voltage level of the parallel I/O and TAP interfaces can be set to any voltage between 1.25 V and 3.30 V in increments of 0.05V minimum.

## Parallel Input/Output Ports

The PCIe-1149.1 contains 16 parallel inputs and 16 parallel outputs. The board groups these digital I/O into two 8-bit parallel input ports, and two 8-bit parallel output ports: Port A and Port B. The host computer can access the output ports via the Corelis ScanPlus Runner software. The input ports are for future use and are not currently available to the user.

The output ports are useful for providing discrete signals that control functions on the user target system such as reset, power control, and disable/enable signals for operating non-boundary-scan devices on target boards that include some non IEEE-1149.1 compliant components.

## **PCI Express Interface**

The PCIe-1149.1 is a single lane (x1) PCI Express add-in card, compatible with all compliant PCIe slots (x1, x4, x8, x16). It is mapped to 132 MB of memory space of the host system as established during system initialization.

## **Programmable Clocks**

The PCIe-1149.1's programmable TCK outputs to the IEEE Standard 1149.1 compatible target system can generate a wide range of TCK frequencies with onboard TCK generation circuitry. A programmable Phase Locked Loop (PLL) and counter dividers provide both a wide range and fine selection resolution. See Table 1-1 for the set of programmable values.

TCK range (MHz)	Rate Resolution (MHz)
25 to 80	1
12.5 to 25	0.5
6.25 to 12.5	0.25
5 to 6.25	0.125
2.5 to 5	0.10
1.25 to 2.5	0.05
0.62 to 1.25	0.025
0.39 to 0.62	0.0156
0.05 to 0.39	0.05

Table 1-1. Programmable TCK Frequencies

## Features of the ScanTAP-4

The Corelis ScanTAP-4 Multiple TAP Intelligent pod connects to the PCIe-1149.1 boundary-scan controller via the 68-pin SCSI II type HOST connector. No external power supply is required—the PCIe-1149.1 card supplies it. Differential signal driving supports cables of up to 30 feet. Automatic delay mechanisms compensate for transport delays through the cable. The four TAPs are individually configurable for interface voltages from 1.25 to 3.3 V. On-board voltage translation logic allows a host to chain these TAPs together, or to configure them for gang programming. During gang programming each TAP drives the same data out to up to four targets, and simultaneously programs and verifies them. Optional Slow Slew rate (Voltages limited to 1.8 V to 3.3 V for slow slew) is provided. Each TAP can detect power shorts to ground for up to 2 voltages per TAP (with user-provided test software), allowing the ScanTAP-4 to detect potentially damaging conditions before the target system(s) is powered up.

Refer to Chapter 4 for further explanation on how to configure the ScanTAP-4 when using ScanPlus Runner or ScanExpress Runner software tools.

## **PCIe-1149.1 Specifications**

#### Host Computer

CPU	Pentium III @ 1 GHz or better
Operating System	Windows 2000 or XP

#### PCI Express Interface

Width	Single Lane (x1)
Memory Space Size	132 MB

#### ScanTAP Interface

Maximum TCK frequency	80 MHz
TCK frequency steps	1.00 MHz increments between 25 and 80 MHz
TCK frequency steps (cont'd)	0.80 MHz increments between 12.5 and 25 MHz
TCK frequency steps (cont'd)	0.25 MHz increments (or less) below 12.5 MHz
Maximum scanning data length	unlimited

#### **Physical**

Card Outline Dimensions (PCB)  $3.875 \pm 0.25$  inches  $\times 6.75 \pm 0.25$  inches

#### I/O Connectors

P3 - Boundary-scan Connector	68-pin SCSI II	type (AMP P/N 787171-7 or equivalent)
P1 - Input Port Connector	34-pin header	(3M part no. 2534-6002UB or equivalent)
P2 - Output Port Connector	34-pin header	(3M part no. 2534-6002UB or equivalent)

#### Power Requirements (from host expansion bus)

3.3 V 1.5 Amps maximum

#### On-board Fuse (feeds power from PCIe-1149.1 to external pod)

1.5 Amp, SLO-BLO	Littelfuse part number 045401.5
------------------	---------------------------------

#### **Operating Environment**

Temperature	0°C to 55°C
Relative Humidity	10% to 90%, non condensing

#### Storage Environment

Temperature

-40°C to 85°C

## **ScanTAP-4 Specifications**

#### PCIe-1149.1 Interface

Host Connector Host Cable Length:	68-pin SCSI type (AMP part no. 787171-7 or equivalent) 6 foot (standard) - Corelis P/N 15314 15 foot (optional) - Corelis P/N 15328 30 foot (optional) - Corelis P/N 15329
TAP Interface	
Connectors	Four 20-pin shrouded headers, 0.1 in. $\times$ 0.1 in. spacing
Number of TAPs	4
Maximum TCK frequency	80 MHz (Concurrent scanning at all TAPs occurs at up to the full TCK rate capability of the PCIe-1149.1)
Maximum scanning data length	unlimited
Programmable Interface Voltage	1.25 to 3.3 V in 0.05 V increments
Programmable TAPs	4, each TAP can have its own programmable voltage settings
Signals DC characteristics	See Table 1-2

Symbol	Test Conditions	Limit Min	Limit Max	Units
V <sub>IH</sub>	Vdd Adjust >= 2.5 V	2	Vdd + 0.5	V
	Vdd Adjust < 2.50 V	$0.65 \times Vdd$	Vdd + 0.5	V
V <sub>IL</sub>	Vdd Adjust >= 2.00		0.7	V
	Vdd Adjust <= 2.0		$0.35 \times Vdd$	V
V <sub>OH</sub>	I <sub>OH</sub> = -2 mA	Vdd – 0.35		V
V <sub>OL</sub>	$I_{OL} = 2 \text{ mA}$		0.45	V
	Vdd =1.65 V			
I <sub>OH</sub>	Vdd = 1.65-1.95 V		-4	mA
I <sub>OL</sub>	Vdd = 1.65-1.95 V		4	mA

#### Table 1-2. ScanTAP-4 DC Characteristics

Note: Also refer to Low Voltage CMOS (LVC) family signal characteristics data available from TI.

 $\underline{\textbf{SPI Interface}} \ \ \text{- available on ScanTAP-4 units P/N 10302A or later (with blue power-on LED)}$ 

SCK frequency	1 MHz
Signal DC Characteristics	See Table 1-3:

Symbol	Test Conditions	Limit Min	Limit Max	Units
$\mathrm{V}_{\mathrm{IH}}$	Vdd Adjust >= 2.5 V	2	Vdd + 0.5	V
	Vdd Adjust < 2.50 V	$0.65 \times Vdd$	Vdd + 0.5	V
V <sub>IL</sub>	Vdd Adjust $\geq 2.00$		0.7	V
	Vdd Adjust <= 2.0		$0.35 \times Vdd$	V
V <sub>OH</sub>	I <sub>OH</sub> = -2 mA	Vdd – 0.35		V
V <sub>OL</sub>	$I_{OL} = 2 \text{ mA}$ Vdd =1.65 V		0.45	V
I <sub>OH</sub>	Vdd = 1.65-1.95 V		-4	mA
I <sub>OL</sub>	Vdd = 1.65-1.95 V		4	mA

Table 1-3. ScanTAP-4 SPI Interface DC Characteristics

I2C Interface - available on ScanTAP-4 units P/N 10302A or later (with blue power-on LED)

100 kHz

The ScanTAP-4 I2C interface has open-drain outputs and the SDA/SCL signals must be pulled up to 3.3V ( $V_{DD}$ ) by the target.

See Table 1-4:

	Symbol	Test Conditions	Limit Min	Limit Max	Units
	$V_{DD}$		3.0	3.6	V
	$V_{IH}$	V <sub>DD</sub> >= 3.3 V	2.0	3.6	V
	$\mathrm{V}_{\mathrm{IL}}$	$V_{DD} >= 3.3 V$	-0.5	0.8	V
	V <sub>OL</sub>	$I_{OL} = 16 \text{ mA}$	0.0	0.0 0.4	V
		$V_{DD} = 3.3 V$	0.0	0.4	v
	I <sub>OL</sub>	$V_{DD} = 3.3 V$		16	mA

Table 1-4. ScanTAP-4 I2C Interface DC Characteristics

SCL frequency

Signal DC Characteristics

### Power Short Test Pins

Power (Vcc) Sense Pins	2 per TAP connector (Vcc1, Vcc2), 8 total
Vcc Measurement Type	Short to GND detect, Target un-Powered,
	Voltage sense/measurement of +/- 50 VDC
Voltage Sense Resolution	12-bit ADC
Voltage Sense Accuracy	+/- 50 mV

## Physical

Box Outline Dimensions	$4.00 \text{ in.} \times 4.60 \text{ in.} \times 0.75 \text{ in.}$
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## Power Requirements

No external examine needed	Down is provided by the best controller
No external supply needed	Power is provided by the host controller

## **Operating Environment**

Temperature	$0^{\circ}$ C to $55^{\circ}$ C
Relative Humidity	10% to 90%, non condensing

#### Storage Environment

Temperature

-40°C to 85°C

The PCIe-1149.1 product typically consists of the following components:

- PCIe-1149.1 PCI Express based boundary-scan controller card
- PCIe-1149.1 User's Manual

Ensure all materials listed are present and free from visible damage or defects before proceeding. If anything appears to be missing or damaged, contact Corelis at the number listed on the front cover immediately.

The ScanTAP-4 typically consists of the following components:

- ScanTAP-4 box
- Host Cable, 6-foot, 68-pin SCSI type, one-to-one Cable, Corelis P/N 15314
- A set of four 20-pin to 10-pin TAP cables, Corelis P/N 15310

**NOTE**: The actual hardware shipped to the customer may vary depending on the customer order.

When this manual was published the following optional target interface TAP cables were available from Corelis:

- Bag of 4 TAP cables, 20-pin to 16-pin TAP, Corelis P/N 15311
- Bag of 4 TAP cables, 20-pin to 20-pin TAP, Corelis P/N 15312
- Special for RISCwatch / PowerPC, 20-pin to 16-pin TAP, Corelis P/N 15433
- Special for MIPS, 20-pin to 14-pin TAP, Corelis P/N 15425
- Host Cable, 15-foot, 68-pin SCSI type, one-to-one cable, Corelis P/N 15328
- Host Cable, 30-foot, 68-pin SCSI type, one-to-one cable, Corelis P/N 15329

## Software Installation First!

The installation procedure requires the use of software that contains the driver for the PCIe-1149.1 card. Obtain the ScanPlus CD-ROM (or any other Corelis application that supports the PCIe-1149.1 card) in order to proceed with installation. Install the ScanPlus Application Software before installing the PCIe-1149.1 controller. The PCIe-1149.1 controller is a plug-and-play device, and its drivers are installed with the ScanPlus Application Software. Windows will automatically recognize and configure the PCIe-1149.1 the first time it is detected in your system.

## WARNING !

You MUST install the software first – before installing the card. **Do not install the PCIe-1149.1** card until you have successfully installed the application software (ScanPlus, CodeRunner, etc.). Installing the software provides the plug-and-play driver for the card so that the operating system is able to properly detect and configure the card. Installing the card before the software may result in improper card configuration and operation.

## Hardware Installation

Again, make sure to **install the ScanPlus Application Software before installing the PCIe-1149.1 controller.** The PCIe-1149.1 controller is a plug-and-play device, and its drivers are installed with the ScanPlus Application Software. Windows will automatically recognize and configure the PCIe-1149.1 the first time it is detected in your system.

To install the PCIe-1149.1 on a PC:

- Update the PC BIOS and chipset drivers to the latest version from the manufacturer
- Install ScanPlus Applications from the CD, and shut down the PC.
- Remove the PCIe-1149.1 from its package.
- Disconnect the PC power cord from the power source and then remove the enclosure cover from the PC.
- Plug the PCIe-1149.1 board into the PC in an available full height PCI Express slot.
- Use a screw to firmly attach the PCIe-1149.1 card bracket to the PC chassis.
- Close the PC enclosure, apply power and verify that the PC boots up correctly.

Preserve the original packing material for future shipment or storage of the PCIe-1149.1.

In the event that you installed the PCIe-1149.1 controller before installing the software, cancel the Add/Remove Hardware Wizard and install the ScanPlus Applications from the CD. The next time you start the PC, Windows will automatically recognize and configure the PCIe-1149.1.

Once the PCIe-1149.1 is installed in the PC, connect the ScanTAP-4 to the PCIe-1149.1 card using the 68-pin SCSI type host cable:

- Power down (shutdown) the PC
- Plug the 68-pin host cable to the mating connector on the PCIe-1149.1 (that should not protrude from the back of your PC enclosure).
- Plug the other side of the 68-pin host cable to the HOST connector of the ScanTAP-4 box.
- Apply power and verify that the PC boots up correctly. The "ON" LED should be constantly illuminated when the PC is powered up.

## Chapter 3 Connecting to the Target

## **Connecting to the Target**

The connection to the user target (UUT) board/system is done from the ScanTAP-4 Intelligent Pod TAP connectors to mating connectors on the target. The ScanTAP-4 connects to the target via the supplied 1:1 TAP flat cables, P/N 15310, 15311 or 15312. Figure 3-1 shows the top view of the ScanTAP-4 box, including the four TAP connectors which are clearly marked: TAP 1, TAP 2, TAP 3 and TAP 4.



Figure 3-1. ScanTAP-4 20-pin TAP Header Connectors (top view)

While most targets use only a single TAP connector, it is not uncommon that targets contain multiple TAP connectors. Although the 4-connector ScanTAP-4 will accommodate the vast majority of multiple-TAP targets, a target board with more than 4 TAPs requires a different interface. Please contact Corelis for other available products.

The following ScanTAP-4 TAP connectors are connected to the target board:

TAP1	- when the target has a single TAP connector
TAP1 and TAP2	- when the target has 2 TAP interface connectors
TAP1, TAP2 and TAP3	- when the target has 3 TAP interface connectors
TAP1, TAP2, TAP3 and TAP4	- when the target has 4 TAP interface connectors

To connect the TAP connector(s) to the target (UUT):

- Make sure that the target power is OFF.
- Make sure that the **ON** blue LED on top of the ScanTAP-4 is illuminated.
- Install the TAP cable(s) on the ScanTAP-4 TAP connectors.
- Install the other side of the TAP cable(s) on the matching target TAP connectors.
- Now you can turn the target power ON.

Appendix A contains general recommendation for implementing compatible target TAP connector(s). Following these recommendations makes the connection to the target easy and straightforward. To accommodate target boards with TAP connectors other than this standard, Corelis offers short, custom adapter cables for connectors such as the Altera ByteBlaster connector, the Xilinx 9 pin header, the Lattice TAP connector or the TI 14 pin DSP connector)

## 20-Pin ScanTAP Connector

The ScanTAP-4 contains four 20-pin TAP connectors. All four connectors have the same signals and the same pinout. Each connector is a shrouded header ( $0.100 \times 0.100$  in. spacing) with long ejectors that are compatible with standard 20-pin IDC flat cable connectors (with strain relief). The pin assignment is shown in Table 3-1.

Pin	Signal	Direction	Termination
1	TRST* Input to the UUT		1K pull-up
2	GND		
3	TDI	Input to the UUT	1K pull-up
4	GND		
5	TDO	Output of the UUT	33 ohm series
6	GND		
7	TMS	Input to the UUT	1K pull-up
8	GND		
9	TCK	Input to the UUT	1K pull-up
10	GND		
11	11Write_Strobe* / GPIO1 / SPI_CS2*Input to the UUT		1K pull-up
12	GND		
13     SPI_SCK / GPIO2     Input to t		Input to the UUT	1K pull-up
14	GND		
15	Ready_Busy* / SPI_SDO (MISO) / GPIO3Output of the UUT		1K pull-up
16	SPI_SDI (MOSI)	Input to the UUT	1K pull-up
17	VCC1	UUT Power Test Point 1	None
18	I2C_SCL	Input to the UUT	1K pull-up
19	VCC2	UUT Power Test Point 2	None
20	SPI_CS1* / I2C_SDA	Input to the UUT	1K pull-up

Table 3-1.	ScanTAP-4	TAP I	Pin	Assignment
------------	-----------	-------	-----	------------

Note that only the first 10 pins are required. For Flash Programming with external write or the Ready Busy signal, use the first 16 pins of the TAP. To build in support for power-to-ground short checking, use all 20 pins of the TAP.

Pins 17 and 19 of each ScanTAP-4 connector can be used to sense that the target power pin is not shorted to GND. Up to 2 different power pins can be checked on each of the four 20-pin connectors of the ScanTAP-4 box.

The 3 GPIO signals are general purpose output signals that are directly controlled by the Parallel I/O menu of ScanPlus Runner. Refer to the ScanPlus Runner manual for further information.

The dual purpose External Write\* (GPIO1) signal is used for Flash programming, and if used will override the Parallel Output (GPIO1) function. Refer to the ScanPlus Flash Programmer manual for further information about this function.

The dual purpose Read/Busy\* (GPIO3) signal is used for Flash programming, and if used will override the Parallel Output (GPIO3) function. Refer to the ScanPlus Flash Programmer manual for further information about this function.

The ScanTAP-4 comes standard with 4 short cables that connect it to a target system with up to 4 TAP connectors. These 20-pin to 10-pin cables, Corelis P/N 15310, are standard flat cables and can easily be made from off-the-shelf connectors. Each cable mates with a matching 10-pin header on the target system.

## **68-pin Host Connector**

The PCIe-1149.1 connects to the ScanTAP-4 using a 68-wire, one-to-one, twisted-pair ribbon cable, P/N 15314. Other HOST cables of longer lengths are also available.

Table 3-2 shows the part numbers for making custom length HOST flat cable. Note that this table is provided for reference only and Corelis recommends using only approved HOST cables that are provided with the product:

Description	Manufacturer	Part Number
68-pin .100 × .100 SCSI IDC Socket	Circuit Assembly	CA-68MDP-F
SCSI Strain Relief	Circuit Assembly	CA-LSR68MDP
0.25" Spectra-Strip twisted pair, 34-pair cable.	Amphenol	125-3099-999

Table 3-2.	68-Pin SCSI type Cable Parts
------------	------------------------------

## PCIe-1149.1 Parallel I/O Connectors

The parallel output port connector (P2 on the PCIe-1149.1) is a 34-pin connector that includes all of the signals for the parallel output ports A and B. The connector is located near the top of the card. The pin-out of the P2 connector is shown in Table 3-3.

Data Bus Alignment	Signal Name	Output Connector
D0	PORTA_OUT0	P2-1
D1	PORTA_OUT1	P2-3
D2	PORTA_OUT2	P2-5
D3	PORTA_OUT3	P2-7
D4	PORTA_OUT4	P2-9
D5	PORTA_OUT5	P2-11
D6	PORTA_OUT6	P2-13
D7	PORTA_OUT7	P2-15
D0	PORTB_OUT0	P2-17
D1	PORTB_OUT1	P2-19
D2	PORTB_OUT2	P2-21
D3	PORTB_OUT3	P2-23
D4	PORTB_OUT4	P2-25
D5	PORTB_OUT5	P2-27
D6	PORTB_OUT6	P2-29
D7	PORTB_OUT7	P2-31

Table 3-3. Connector P2 Parallel Output Pin Assignment

Note: All even pins of the connector (2, 4, 6, 8, ...34) are connected to ground. P2-33 is not connected.

The parallel input port connector (P1 on the PCIe-1149.1) is a 34-pin connector that includes all of the signals for the parallel input port. The connector is located near the top of the card. The pinout of the P1 connector is shown in Table 3-4.

Data Bus Alignment	Signal Name	Input Connector
D0	PORTA_IN0	P1-1
D1	PORTA_IN1	P1-3
D2	PORTA_IN2	P1-5
D3	PORTA_IN3	P1-7
D4	PORTA_IN4	P1-9
D5	PORTA_IN5	P1-11
D6	PORTA_IN6	P1-13
D7	PORTA_IN7	P1-15
D0	PORTB_IN0	P1-17
D1	PORTB_IN1	P1-19
D2	PORTB_IN2	P1-21
D3	PORTB_IN3	P1-23
D4	PORTB_IN4	P1-25
D5	PORTB_IN5	P1-27
D6	PORTB_IN6	P1-29
D7	PORTB_IN7	P1-31

Table 3-4. Connector P1 Parallel Input Pin Assignment

- Note 1: All even pins of the connector (2, 4, 6, 8, ...34) are connected to ground. P1-33 is not connected.
- **Note 2:** All input signals have a 4.7 K pull-up resistor to the programmed interface voltage (1.25 to 3.30 V). When the ScanTAP-4 is used, the 16 inputs and outputs interface at 3.3V.

## Hardware Setup

You must configure the PCIe-1149.1 controller in a ScanPlus application before the application can use it. This chapter uses ScanPlus Runner as an example to illustrate the configuration process.

## Using PCIe-1149.1 with ScanPlus Tools

The PCIe-1149.1 card is compatible with ScanPlus Runner, ScanPlus Debugger and ScanPlus Flash Programmer. The following steps are provided for ScanPlus Runner. Selecting the card in ScanPlus Debugger or ScanPlus Flash Programmer is done in a similar fashion.

- **1.** Invoke the ScanPlus Runner application.
- **2.** Click the **Setup** menu item and then select the **Controller** entry to display the Controller Configuration screen shown in Figure 4-1.

Configuration	X
Test Plan Generation User Settings	Controller Configuration Parallel Outputs
Controllers	Controller Settings
Current Controller	
	OK Cancel Apply Help

Figure 4-1. Controller Configuration Screen

- **3.** Select the **PCIe-1149.1** controller from the icons on the left. Adjust the settings to the desired values.
- **4.** After you have made your selections, click on the **Apply** button to test and save the settings. When the program saves the settings successfully, it displays the controller in the **Current Controller** box. If ScanPlus Runner cannot find the controller, it displays an error dialog.
- **5.** Once ScanPlus Runner finds the PCIe-1149.1 controller, **if for some reason the ScanTAP-4 is not connected to it,** it displays a screen similar to Figure 4-2. If the ScanTAP-4 is connected after seeing this screen you must exit this program and re-start at step 1.

Configuration		×
Test Plan Generation User Settings	Controller Configuration Parallel Outputs	
Controllers	Controller Settings         TAP Voltage       3.30V         TCK Frequency       1.000 MHz         Delay Compensation       Automatic         Image: Compensation in the set of the	
Current Controller	OK Cancel Apply Help	

Figure 4-2. PCIe-1149.1 Setup Screen (but ScanTAP-4 not connected)

6. Once ScanPlus Runner finds the PCIe-1149.1 controller, with the ScanTAP-4 connected to it, it displays a screen similar to Figure 4-3 Note that saving the test plan (.tsp) file in ScanPlus Runner FILE menu also saves the settings in the system registry. The next time the .tsp file is loaded into ScanPlus Runner it will use these settings to initialize the controller.

Controller Configuration		×
Controller Configuration		
Controllers	Controller Settings — TAPs Voltage Input Threshold TCK Frequency Delay Compensation Slew Rate TAP Configuration	3.30V   Automatic   59.000 MHz   59.000 MHz   Automatic   Automatic   I   Automatic
	ОК	Cancel <u>Apply</u>

Figure 4-3. Successful PCIe-1149.1 With ScanTAP Setup Screen

**7.** The **Advanced** button can be used for selecting different voltage settings for each individual TAP. While most targets with multiple TAPs use the same voltage settings for all the TAPs it is not uncommon to find targets that use, for example, the 3.3 V setting for one TAP, 2.5 V for another, and 1.8 V for one or two additional TAPs. The Advanced Configuration screen is shown in Figure 4-4.

ScanTAP Advanced Config	uration			×
Output Voltage TAP1 Voltage 3.30 V TAP2 Voltage 3.30 V	-	Input Threshold TAP1 Threshold TAP2 Threshold TAP3 Threshold	Automatic Automatic	•
TAP3 Voltage 3.30 V TAP4 Voltage 3.30 V		TAP3 Threshold TAP4 Threshold Cancel	Automatic	

Figure 4-4. Advanced Configuration Setup Screen

## **ScanTAP-4 TAP Configuration**

The ScanPlus Tools provide 3 different methods to specify the TAP(s) that connect the ScanTAP-4 to the target system:

- **Method 1** The **TAP Configuration** select box in the **Controller Configuration** screen (see Figure 4-3). This is the preferred and most straightforward method for selecting which of the 4 ScanTAP-4 TAPs to use for connecting to the target.
- **Method 2** Embedding the TAP selection text as part of the test step file name. This method is explained below and is primarily supported for upwards compatibility with legacy tools. This method is not recommended and will no longer be supported in future software releases.
- **Method 3** Using the ScanPlus Runner tool **Options** menu. Use this method only when specific test step(s) require TAP configuration settings different from the global settings selected in Method 1 above.

## **TAP Configuration - Method 1**

The **TAP Configuration** select box in the **Controller Configuration** screen provides TAP selection options as shown in Figure 4-5. This is the preferred and most straightforward method for selecting which of the 4 ScanTAP-4 TAPs to use for connecting to the target. This feature is available in all relevant ScanPlus Tools, including ScanPlus Runner, ScanPlus Debugger and ScanPlus Flash Programmer.

Controller Configuration			x
Controller Configuration			
Controllers	- Controller Settings TAPs Voltage Input Threshold TCK Frequency Delay Compensation Slew Rate TAPs Configuration	1.80V   Automatic   50.000 MHz   Automatic   Automatic   I   1   2   3   4	
	OK	Cancel <u>A</u> pply	

Figure 4-5. Controller Configuration TAP Configuration Options

Table 4-1 summarizes the different configuration options available in the **TAP Configuration** dropdown list.

Configuration	Meaning	TAP(s) Enabled
1	Enable TAP1 only	TAP1 only
2	Enable TAP2 only	TAP2 only
3	Enable TAP3 only	TAP3 only
4	Enable TAP4 only	TAP4 only
1+2	Serialize TAPs 1 through 2	TAPs 1 and 2 in series
1+2+3	Serialize TAPs 1 through 3	TAPs 1, 2, and 3 in series
1+2+3+4	Serialize TAPs 1 through 4	TAPs 1, 2, 3, and 4 in series

#### Table 4-1. ScanPlus Runner ScanTAP-4 Configuration

**NOTE:** Additional selection options are available for Flash Programming (.fpi) test steps as described later in this chapter.

## **TAP Configuration - Method 2**

This method is primarily provided for upwards compatibility with legacy tools and is not recommended for new applications. It works by embedding the TAP selection text as part of the test step file name. This method will override any TAP configuration selected in Method 1. This feature is available in all relevant ScanPlus Tools, including ScanPlus Runner, ScanPlus Debugger and ScanPlus Flash Programmer.

File Name ID	Meaning	TAP(s) Enabled
_TAP1	Enable TAP1 only	TAP1 only
_TAP2	Enable TAP2 only	TAP2 only
_TAP3	Enable TAP3 only	TAP3 only
_TAP4	Enable TAP4 only	TAP4 only
_TAP1+2	Serialize TAPs 1 through 2	TAPs 1 and 2 in series
_TAP1+2+3	Serialize TAPs 1 through 3	TAPs 1, 2, and 3 in series
_TAP1+2+3+4	Serialize TAPs 1 through 4	TAPs 1, 2, 3, and 4 in series

Table 4-2. ScanPlus Runner Naming Conventions

For example, to execute a test or programming file on a target board that contains 3 TAPs using the file **myboard\_inf.cvf**, change the file name to **myboard\_TAP1+2+3\_inf.cvf**. The ScanTAP-4 is configurable on the fly, and adding a filename suffix from Table 4-2 to a test file name will configure the system to run that test.

Note that since in most cases the file name already contains a suffix, the file name ID is inserted between the suffix and the rest of the file name. For example, infrastructure\_inf.cvf becomes infrastructure\_TAP1+2+3+4\_inf.cvf.

**NOTE:** Additional selection options are available for Flash Programming (.fpi) test steps as described later in this chapter.
# **TAP Configuration - Method 3**

This method is only available for ScanPlus Runner. It is available in the ScanPlus Runner **Options** menu. Use this method only when specific test step(s) require TAP configuration settings different from the global settings selected in Method 1.

A typical ScanPlus Runner main screen with multiple test steps is shown in Figure 4-6:

3	🐱 ScanPlus Runner - TARGET-1149.1.tsp						
Ei	<u>File Setup Diagnostics View H</u> elp						
$\left[ \cdot \right]$	Test Steps:						
	#	Test Step Name		Results			
	1	infrastructure_inf.cvf		Not Tested			
	2	interconnect_ic.cvf		Not Tested			
	3	buswire_bus.cvf		Not Tested			
	4	fifo_mct.cvf		Not Tested			
	5	dram_mct.cvf		Not Tested			
	6	Program U12 LEDs ON_Altera.svf		Not Tested			
	7	Program U18 LEDs OFF_Xilinx.svf		Not Tested			
	8	Demo_Board_U10_Ext_HEX.fpi		Not Tested			
יו							
l r	- Test	Status	Test Statistics				
	Stati	us Ready	Total Runs				
	Jian			$= ( ) \perp$			
	_		Passed Runs	0 ( )			
	Res	ults No Data	Failed Runs				
	<u>R</u> un Test <u>C</u> lose						
				1			
1							

Figure 4-6. Typical ScanPlus Runner Test Plan

Highlight a test step by pointing to it with the mouse and then clicking once with the left mouse button. The test step is now highlighted. Right-click on the test step name to bring up a pop-up menu, and select **Options** as shown in Figure 4-7.

🛃 ScanPlus Runner - TARGET-1149.1.tsp					
<u>File Setup Diagnostics View</u>	<u>H</u> elp				
Test Steps:					
# Test Step Name			Results		
I         infrastructure_inf.cvf           2         interconnect_ic.cvf           3         buswire_bus.cvf           4         fifo_mct.cvf           5         dram_mct.cvf           6         Program U12 LEDs Of	Enable All Disable All Enable Selected Disable Selected		Not Tested Not Tested Not Tested Not Tested Not Tested Not Tested		
7 Program U18 LEDs OF 8 Demo_Board_U10_E× -	Edit Test Steps		Not Tested Not Tested		
	View Diagnostics		Not rested		
– Test Status – – – – – – – – – – – – – – – – – – –	Debug	istics			
Status Ready	Clear Statistics	Runs 📃			
Results No Da	Options Help	Runs Runs			
<u>R</u> un Test <u>C</u> lose					

Figure 4-7. ScanPlus Runner Pop-up Menu

An **Options** dialog box similar to Figure 4-8 will appear. The appearance of the dialog box varies with the type of test step selected. Figure 4-8 illustrates an options dialog for an infrastructure test step. Consult the ScanPlus Runner User's Manual for more information on the **Options** dialog boxes.

In	frastructure Test Step Options	×		
1		-		
	Skip Pre-test Reset Sequence			
	Set Pre-test Parallel I/Os Hex Value to: 0000			
	Use the following ICK (MHz):			
	Loop on Test Step			
	Use the following ScanTAP configuration: 1			
		_		
	OK Cancel Defaults			

Figure 4-8. Infrastructure Test Options Dialog Box

Click the **Use the following ScanTAP configuration** check box and select the desired programming topology configuration from the drop-down list. Figure 4-9 shows the selections available from the configuration drop-down list.



Figure 4-9. Available ScanTAP-4 Configuration

## Gang Programming with ScanPlus Runner

Special TAP configuration features are provided for parallel (Gang) programming of Flash memories using .fpi files. ScanPlus Runner also supports gang programming, determining the configuration of the Flash programming topology from the .fpi file name. This is in addition to the TAP configuration options listed .

File Name ID	Meaning	TAP(s) Enabled
_TAP1-2	Enable TAPs 1 through 2	Gang Programming of TAP1 and TAP2
_TAP1-3	Enable TAPs 1 through 3	Gang Programming of TAP1, TAP2 and TAP 3
_TAP1-4	Enable TAPs 1 through 4	Gang Programming of TAPs 1, 2, 3 and 4

Table 4-3 lists suffixes to add to the file name for various cases:

#### Table 4-3. ScanPlus Runner Naming Conventions for Gang Programming

For example, to gang program all four target boards using the file **program U7.fpi**, change the file name to **program U7\_TAP1-4.fpi**. The ScanTAP-4 is configurable on the fly, and adding a filename suffix from Table 4-3 to a test file name will configure the system to run that test.

In the test plan shown in Figure 4-10 below, the system first tests target TAPs 1 through 4 for infrastructure, then it programs the Altera CPLD on target TAPs 1 through 4, then it programs the Flash memory in parallel on all four targets.

Note that for files that already contain a suffix, the file name ID is inserted between the suffix and the rest of the file name. For example, infrastructure\_inf.cvf becomes infrastructure\_TAP1-4\_inf.cvf.

💑 ScanPlus Runner - Untitled *					
<u>File Setup Diagnostics View Help</u>					
Test Steps:					
# Test Step Name	Results				
1 infrastructure_TAP1_inf.cvf	Not Tested				
2 infrastructure_TAP2_inf.cvf	Not Tested				
3 infrastructure_TAP3_inf.cvf	Not Tested				
4 infrastructure_TAP4_inf.cvf	Not Tested				
5 Program_U12_TAP1_Altera.svf	Not Tested				
6 Program_U12_TAP2_Altera.svf	Not Tested				
7 Program_U12_TAP3_Altera.svf	Not Tested				
8 Program_U12_TAP4_Altera.svf	Not Tested				
9 Program_U7_TAP1-4.fpi	Not Tested				
Test Status	Test Statistics				
Status Ready	Total Runs 0				
Data No Data	Passed Runs 0 ( )				
Results No Data	Failed Runs 0				
<u>R</u> un Test	<u>C</u> lose				

Figure 4-10. ScanPlus Runner Test Plan for Gang Programming

The **Options** dialog provides an alternate way to specify gang programming from ScanPlus Runner. Right-click on the test step name to bring up a pop-up menu, and select **Options** as shown in Figure 4-11.

🧏 ScanPlus Runner - Untitled		
File Setup Diagnostics View Help		
Test Steps:		
# Test Step Name		Results
1       infrastructure_inf.cvf         2       infrastructure_inf.cvf         3       infrastructure_inf.cvf         4       infrastructure_inf.cvf         5       Program_U12_Altera.svf         6       Program_U7.fpi	Enable All Disable All Enable Selected Disable Selected	Mot Tested Tested Tested Tested Tested Tested
	Edit Test Steps	
	View Diagnostics	
Test Status	Debug	
Status Ready To	Clear Statistics	
Results No Data Fai	Options	
	Help	
<u>B</u> un Test	<u>C</u> lose	

Figure 4-11. ScanPlus Runner Pop-up Menu

An **Options** dialog box similar to Figure 4-12 will appear. The appearance of the dialog box varies with the type of test step selected. Figure 4-12 illustrates an options dialog for an infrastructure test step. Consult the ScanPlus Runner User's Manual for more information on the **Options** dialog boxes.

Ir	frastructure Test Step Options	×		
	Set Pre-test Reset Sequence     Set Pre-test Parallel I/Os Hex Value to:			
	Use the following <u>I</u> CK (MHz): 50.000			
	Loop on Test Step			
	Use the <u>following</u> ScanTAP configuration: 1			
	OK Cancel Defaults			

Figure 4-12. Infrastructure Test Options Dialog Box

Click the **Use the following ScanTAP configuration** check box and select the desired programming topology configuration from the drop-down list. Figure 4-13 shows the selections available from the configuration drop-down list.



Figure 4-13. Available ScanTAP-4 TAP Configuration

Note that the same drop-down options list contains additional configuration options for the .fpi (programming) test steps. These additional configuration options are only available for Gang Flash programming of .fpi files and is not shown for regular test steps (.cvf files). See Figure 4-14.

Flash Programming Test Step Options					
Skip Instruction Register Initialization					
Disable scan chain integrity check					
Enable fix for Xilinx Virtex Engineering Sample parts					
Set Pre-test Parallel I/Os Hex Value to: 0000					
Use the following ICK (MHz): 50.000					
Loop on Test Step					
Use the following ScanTAP configuration: 1					
2					
Check Device ID Prior to Programming					
Erase Entire Flash Prior to Programming					
In the sector secto					
Check Interconnect Prior to Programming     1+2+3     1+2+3+4					
Perform <u>B</u> lank Check Prior to Programming					
Do Not Program Device					
Poll for DONE Status While Programming					
🔲 Use Little Endian Byte Ordering					
□ Verify Flash After Programming					
Address Offset (hex) Subtract					
External Write Utilization is ON					
External RDY/BSY is ON					
OK Cancel Defaults					

Figure 4-14. Available ScanTAP-4 TAP Configuration for .fpi files

Table 4-4 summarizes the additional, .fpi file-specific, configuration options available in the dropdown list.

Configuration Meaning		TAP(s) Enabled
1-2 Enable TAPs 1 through TAP2 in parallel (Gang)		TAPs 1 and 2 are active
1-3 Enable TAPs 1 through TAP3 in parallel (Gang)		TAPs 1, 2 and 3 active
1-4	Enable TAPs 1 through TAP4 in parallel (Gang)	All 4 TAPs are active

Table 4-4. ScanPlus Runner ScanTAP-4 Configuration

## Gang Programming with ScanPlus Flash Programmer

Version 1.73 or newer of the ScanPlus Flash Programmer software supports gang programming of multiple target boards using ScanTAP-4. Gang programming with the ScanTAP-4 requires an .fpi file that the ScanPlus Flash Generator generates. Gang programming applies the same .fpi file to identical targets concurrently via separate TAP connections.

Invoke ScanPlus Flash Programmer, select the **Setup** menu item, and the **Gang Programming** entry. Then check off the TAPs on which you are programming the Flash Devices.

Figure 4-15 below shows the setup for programming four targets in parallel.

Gang Programming
Indicate below which boards are currently connected. If you are not using a controller which supports Gang Programming operations, select only Board #1.
Board #1 is connected to the Boundary Scan controller
☑ Board #2 is connected to the Boundary Scan controller
☑ Board #3 is connected to the Boundary Scan controller
Board #4 is connected to the Boundary Scan controller
OK Cancel

Figure 4-15. ScanPlus Flash Programmer Gang Programming Window

ScanPlus Runner provides a general purpose, third-party application interface that includes specifying the correct controller card and settings. This section clarifies the requirements related to the PCIe-1149.1 card and to the ScanTAP-4. Refer to the ScanPlus Runner manual for further information.

# Using PCIe-1149.1 with ScanPlus Runner Command-line

You can invoke ScanPlus Runner with special command line parameters to execute a Test Step file, provide test results and diagnostic messages in a log file (if you have the ScanPlus Runner ADO), and then terminate. The following table shows the controller identifiers and associated parameters. Consult the ScanPlus Runner User's Manual for more detail.

The PCIe-1149.1 controller without ScanTAP4 uses three parameters and it uses up to fourteen parameters with ScanTAP4. The parameters are described in the table below.

Position	Parameter	Value	Setting
1	TAPs Voltage	1 2  41 42 43	<ul> <li>1.25 V</li> <li>1.30 V</li> <li> (0.05 volts per step)</li> <li>3.25 V</li> <li>3.30 V</li> <li>Use advanced voltage settings in position 7 through 10</li> </ul>
2	Clock Frequency	51	80 MHz
			(1 MHz increment)
		76	25 MHz
		77	24.5 MHz
			(0.5 MHz increment)
		101	12.5 MHz

Controller keyword: PCIe-1149.1, PCIe-1149.1+ScanTAP4

Position	Parameter	Value	Setting
		102	12.25 MHz
			(0.25 MHz increment)
		126	6.25 MHz
		127	6.125 MHz
			(0.125 MHz increment)
		136	5 MHz
		137	4.9 MHz
			(0.1 MHz increment)
		161	2.5 MHz
		162	2.45 MHz
			(0.05 MHz increment)
		186	1.25 MHz
		187	1.225 MHz
			(0.025 MHz increment)
		211	.625 MHz
		212	.609MHz
			(0.0156 MHz increment)
		226	.391MHz
		227	.350 MHz
			(0.05 MHz increment)
		233	.050 MHz

Table 5-1. PCIe-1149.1 Controller Parameters

Position	Parameter	Value	Setting
3	Delay	1	Automatic
	Compensation	2	No Delay
		3	0.5 Clock Delay
		4	1.0 Clock Delay
		5	1.5 Clock Delay
		6	2.0 Clock Delay
		7	2.5 Clock Delay
			(the following are for PCIe-1149.1 without ScanTAP only)
		0	3.0 Clock Delay
		8	(0.5 clock increment)
		•••	14.5 Clock Delay
		31	15.0 Clock Delay
		32	
4	Input Threshold	1	Automatic
		2	Use advanced input threshold settings in position 11 through 14
5	Slew Rate	1	Automatic
		2	Slow slew rate
		3	Normal slew rate
6	TAPs Configuration	1 2 3	Use TAP1 Use TAP2 Use TAP3
		4	Use TAP4
		5 5	Use TAPs 1 and 2 in series Use TAPs 1, 2, and 3 in series
		3 7	Use TAPs 1, 2, 3, and 4 in series

Position	Parameter	Value	Setting
7	TAP1 Voltage	1 2 3  40 41 42	1.25 V 1.30 V 1.35 V (0.05 V per step) 3.20 V 3.25 V 3.30 V
8	TAP2 Voltage	1 2 3  40 41 42	1.25 V 1.30 V 1.35 V (0.05 V per step) 3.20 V 3.25 V 3.30 V
9	TAP3 Voltage	1 2 3  40 41 42	1.25 V 1.30 V 1.35 V (0.05 V per step) 3.20 V 3.25 V 3.30 V
10	TAP4 Voltage	1 2 3  40 41 42	1.25 V 1.30 V 1.35 V (0.05 V per step) 3.20 V 3.25 V 3.30 V
11	TAP1 Input Threshold	1	Automatic
12	TAP2 Input Threshold	1	Automatic
13	TAP3 Input Threshold	1	Automatic
14	TAP4 Input Threshold	1	Automatic

### Example:

To select a PCIe-1149.1 controller card with a TAP1 voltage of 3.30 V, TCK frequency of 1 MHz, and automatic delay compensation, use this "controller specification" string:

```
-controller "PCIe-1149.1,42,196,1,,,,"
```

To select a PCIe-1149.1+ScanTAP4 controller card with all TAP voltages of 3.30 V, TCK frequency of 1 MHz, automatic delay compensation, automatic input threshold, slow slew rate and TAP1, use this "controller specification" string:

-controller "PCIe-1149.1+ScanTAP4,42,196,1,1,1,1,42,42,42,42,42,1,1,1,1"

# Appendix A Recommended Target Connectors

## **10-pin TAP Connector**

The Boundary-Scan TAP is a well defined IEEE-1149.1-compatible electrical interface between boundary-scan test equipment and the boundary-scan compatible devices in the user's target board. Boundary-scan based test equipment, such as the Corelis ScanPlus family of products, utilize a single TAP to interface to the UUT. This section explains how to implement a TAP connector that is compatible with most standard test equipment.

The TAP contains 5 signals: TCK, TMS, TDO, TDI and optionally TRST\*. It also contains ground signal(s). Corelis recommends the standard TAP connector shown in Figure A-1, which is widely regarded as the industry standard. Note that each signal is terminated with a resistor (discussed below) in order to improve noise immunity.

The connector on the user's target should have a standard flat cable compatible pinout to match the TAP connector described in Table A-1. Figure A-1 shows the top view of the basic target 10-pin connector header  $(0.100 \times 0.100 \text{ in. spacing})$ :

TRST*	1		2	GND
TDI	3		4	GND
TDO	5		6	GND
TMS	7		8	GND
ТСК	9		10	GND

Figure A-1. Standard TAP connector (top view)

Table A-1 describes the 10 pin TAP connector signals and Corelis recommended values of terminating resistors:

Pin	Signal	Direction	Termination	
1	TRST*	Input to the UUT	1K pull-up (or 1.5K pull-down)~	→ Note: Some target
2	GND			boards may require a
3	TDI	Input to the UUT	1K pull-up	pull-down resistor on the TRST* signal to
4	GND			assure normal device
5	TDO	Output of the UUT	33 ohm series	operations when not in boundary-scan test
6	GND			mode.
7	TMS	Input to the UUT	1K pull-up	
8	GND			
9	TCK	Input to the UUT	1K pull-up	
10	GND			

 Table A-1. Signal Description and Termination

Table A-2 summarizes the specifications for the 10-pin TAP connector. Equivalent connectors are available from other manufacturers.

Reference	Description	Manufacturer	Part Number
10-Pin Target TAP	Straight header, 10-pin, 4 wall, with center notch	3M	3473-6610

Table A-2. Standard 10-Pin TAP Connector

Figure A-2 shows a typical schematic of the target TAP connector with the recommended termination resistors. The 1K pull-up resistors should connect to the target Vcc supply corresponding to the interface voltage (programmable on the PCIe-1149.1 from 1.25 to 3.3 V). Recommended resistor values are +/-5%.



Figure A-2. TAP Connector Schematic

### Flash Programming TAP Connector

To build in support for in-circuit programming of flash or microprocessor devices, Corelis recommends including supplemental control signals in the TAP interface. The ScanPlus Flash Programmer can use a 16-pin TAP, similar to Figure A-3, to improve programming time. This interface adds Write\_Strobe\*, Ready/Busy\*, and ground signals to the standard 5-signal interface. Terminating resistors (see Table) can improve signal quality.

TRST	* 1		2	GND
TDI	3	⊠	4	GND
TDO	5	⊠	6	GND
TMS	7	L Ŋ⊠	8	GND
ТСК	9		10	GND
Write_Strobe*	11		12	GND
Reserved	13		14	Do Not Connect
Ready/Busy*	15		16	Do Not Connect

Figure A-3. Boundary-scan Flash Programming 16 Pin TAP Connector (top view)

Corelis' Flash Programming software supports the external signals Write\_Strobe\* and Ready/Busy\*, in addition to the standard but slower scanned out/in signals approach.

The Write\_Strobe\* signal is active low and should be pulled up with a 1K resistor on the target board. It needs to be logically ORed with the flash Write-Enable (WE\*) signal so that either the flash Write-Enable (WE\*) signal or the external Write\_Strobe\* going low will assert the flash WE\* input.

The active low Ready/Busy\* signal is typically an open-collector/open-drain signal that ties directly to the same signal(s) on the Flash device(s). This enables multiple devices to drive it toward the PCIe-1149.1.

Table A-3 summarizes the specifications for a 16-pin TAP connector without latch ejector. Equivalent connectors are available from other manufacturers.

Reference	Description	Manufacturer	Part Number
Flash TAP	Straight header, 16-pin, 4 wall, with center notch	3M	2516-6002UG

Table A-3. Flash Programming TAP 16 Pin Connector

Table A-4 describes the signals and Corelis recommended values of terminating resistors:

Pin	Signal	Direction	Termination		<b>Note:</b> Some target boards may require a
1	TRST*	Input to the UUT	1K pull-up (or 1.5K pull-down) –	*	pull-down resistor on the TRST* signal to
2	GND				assure normal device
3	TDI	Input to the UUT	1K pull-up		operations when not in boundary-scan test
4	GND				mode
5	TDO	Output from UUT	33 ohm series		
6	GND			•	<b>Note:</b> The target
7	TMS	Input to the UUT	1K pull-up		TDI signal is driven
8	GND				by the TDO signal of the boundary-scan
9	TCK	Input to the UUT	1K pull-up		controller
10	GND				
11	Write_Strobe*	Input to the UUT	1K pull-up		
12	GND			•	Note: The target
13	Reserved				TDO signal drives
14	Reserved				the boundary scan controller's TDI
15	Ready/Busy*	Output from UUT	1K pull-up		signal
16	Reserved				

 Table A-4.
 Signal Description and Termination

Figure A-4 shows a typical schematic of the target TAP connector with termination resistors. The 1K pull-up resistors should connect to the target Vcc supply corresponding to the interface voltage (programmable on the PCIe-1149.1 from 1.25 to 3.3 V). Recommended resistor values are +/-5%.



Figure A-4. Flash Programming TAP Connector Schematics

### **20-pin TAP Connector**

To build in support for in-circuit programming of flash or microprocessor devices, Corelis recommends including supplemental control signals in the TAP interface. The ScanPlus Flash Programmer can use a 16-pin TAP, similar to Figure A-5, to improve programming time. This interface adds Write\_Strobe\*, Ready/Busy\*, and ground signals to the standard 5-signal interface. Terminating resistors (see Table) can improve signal quality.



Figure A-5. Boundary-scan Flash Programming 20-Pin TAP Connector (top view)

Corelis' Flash Programming software supports the external signals Write\_Strobe\* and Ready/Busy\*, in addition to the standard but slower scanned out/in signals approach.

The Write\_Strobe\* signal is active low and should be pulled up with a 1K resistor on the target board. It needs to be logically ORed with the flash Write-Enable (WE\*) signal so that either the flash Write-Enable (WE\*) signal or the external Write\_Strobe\* going low will assert the flash WE\* input.

The active low Ready/Busy\* signal is typically an open-collector/open-drain signal that ties directly to the same signal(s) on the Flash device(s). This enables multiple devices to drive it toward the PCIe-1149.1.

Table A-3 summarizes the specifications for a 16-pin TAP connector without latch ejector. Equivalent connectors are available from other manufacturers.

Reference	Description	Manufacturer	Part Number
Flash TAP	Straight header, 16-pin, 4 wall, with center notch	3M	2516-6002UG

### Table A-5. Flash Programming TAP 16 Pin Connector

Table A-4 describes the signals and Corelis recommended values of terminating resistors:

Pin	Signal	Direction	Termination	<b>Note:</b> Some target boards may require a
1	TRST*	Input to the UUT	1K pull-up (or 1.5K pull-down)	pull-down resistor on the TRST* signal to
2	GND			assure normal device
3	TDI	Input to the UUT	1K pull-up	operations when not in boundary-scan test
4	GND			mode
5	TDO	Output from UUT	33 ohm series	
6	GND			<b>Note:</b> The target
7	TMS	Input to the UUT	1K pull-up	TDI signal is driven
8	GND			by the TDO signal of the boundary-scan
9	ТСК	Input to the UUT	1K pull-up	controller
10	GND			
11	Write_Strobe* /GPIO1 / SPI_CS2*	Input to the UUT	1K pull-up	
12	GND			<b>Note:</b> The target
13	SPI_SCK /GPIO2	Input to the UUT	1K pull-up	TDO signal drives the boundary scan controller's TDI
14	GND			signal
15	Ready_Busy* / SPI_SDO (MISO) / GPIO3	Output from the UUT	1K pull-up	
16	SPI_SDI (MOSI)	Input to the UUT	1K pull-up	

17	VCC1	UUT Power Test Point	
18	I2C_SCL	Input to the UUT	1K pull-up
19	VCC2	UUT Power Test Point	
20	SPI_CS1* / I2C_SDA	Input to the UUT	1K pull-up

 Table A-6.
 Signal Description and Termination

Figure A-6 shows a typical schematic of the target TAP connector with termination resistors. The 1K pull-up resistors should connect to the target Vcc supply corresponding to the interface voltage (programmable on the PCIe-1149.1 from 1.25 to 3.3 V). Recommended resistor values are +/-5%.



Figure A-6. 20-pin TAP Connector Schematic for SPI

Figure A-7 shows a typical schematic of the target TAP connector with termination resistors. The 1K pull-up resistors should connect to the target Vcc supply corresponding to the interface voltage (programmable on the PCIe-1149.1 from 1.25 to 3.3 V). Recommended resistor values are +/-5%.



Figure A-7. 20-pin TAP Connector Schematic for I2C

The PCIe-1149.1 has a self test utility that can be used to test the card and make sure that it is fully functional. Logic at the TAP connectors can read back data shifted out on TMS and TDO synchronously with the TCK. Using these signal paths, a host can test the TAP signals all the way to the connectors, verifying the overall functionality of the system.

## Self-Test

The self-test utility is provided for off-line confidence test only and **under normal circumstances there is no need to run the self test utility software**. However, if you suspect that the board is damaged, you can run the self-test on the PCIe-1149.1 card. The self-test utility is installed on your computer in the same folder where ScanPlus Applications (ScanPlus Runner, ScanPlus Debugger and ScanPlus Flash Programmer) are installed. Make sure to disconnect any ScanTAP-4 TAP cables before running the test.

Using the Windows Explorer, select and run the *pci1149\_t\_test.exe* file. A small pop-up should appear. The program checks for the presence of a ScanTAP-4, and runs the appropriate test. Make sure that there is no target connected to the controller or to the ScanTAP-4 before running the self-test, as they can cause the test to fail. Click on **Test** to run the self-test.

The program should respond with results similar to the screens shown in Figure B-1 and Figure B-2.

PCI PCI-1149.1/Turbo Self-Test			×
TEST			_
Enable test	Number of Loops	Result	
PCI Communications	1	PASSED	
ADC/DAC/Programmable Voltage	1	PASSED	
Clock Buffers/PLL Operations	1	PASSED	
☑ JTAG Loopback Scan/Control	1	PASSED	
SDRAM Test	1	PASSED	
Divided Clock TCK Operation	1	PASSED	
	1		
📕 Management Bus Test			
ADC/DAC on ScanTAP	1		
POD Event Test	1		
🗖 GPIO Test	1		
Exit Test	Clear	View Results	
1			

Figure B-1. Self-Test Result for the PCIe-1149.1 when the ScanTAP-4 is NOT connected

PCI PCI-1149.1/Turbo Self-Test			×
TEST			_
Enable test	Number of Loops	Result	
PCI Communications	1	PASSED	
ADC/DAC/Programmable Voltage	1		
Clock Buffers/PLL Operations	1	PASSED	
JTAG Loopback Scan/Control	1	PASSED	
SDRAM Test	1	PASSED	
Divided Clock TCK Operation	1	PASSED	
Management Bus Test	1	PASSED	
ADC/DAC on ScanTAP	1	PASSED	
POD Event Test	1	PASSED	
GPIO Test	1	PASSED	
Exit Test	Clear	View Results	

Figure B-2. Self-Test Results for the PCIe-1149.1 with the ScanTAP-4 Connected